

<b>Notice of References Cited</b>	Application/Control No. 10/561,232		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner YU (Andy) GU		Art Unit 2617	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0157640	08-2004	Pirskanen et al.	455/552.1
*	B	US-2003/0236085	12-2003	Ho, Chi-Fong	455/411
*	C	US-6,782,274	08-2004	Park et al.	455/552.1
*	D	US-7,433,334	10-2008	Marjelund et al.	370/329
*	E	US-7,031,694	04-2006	Koulakiotis et al.	455/406
*	F	US-2002/0110106	08-2002	Koo et al.	370/341
*	G	US-2003/0003895	01-2003	Wallentin et al.	455/410
*	H	US-6,850,759	02-2005	Van Lieshout et al.	455/426.1
*	I	US-2004/0266447	12-2004	Terry, Stephen E.	455/450
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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